Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/714,121	KRYKA ET AL.
Examiner	Art Unit
Joon H. Hwang	2166

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Palm inventor searched see search history printout(s)	3/1/2007	JH	
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